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U.S. PATENT DOCUMENTS

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INITIALS NUMBER DATE NAME CLASS SUBCLASS FILING DATE

FOREIGN PATENT DOCUMENTS

<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>COUNTRY</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>TRANSLATION YES</u>	<u>NO</u>
JK	1. 0895183	2/3/99	Europe	—	—	X	
JK	2. 0992365	4/12/00	Europe	—	—	X	

OTHER REFERENCES

(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)

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3. Patent Abstract of Japan, CD-ROM PAJ G03FGH 1987-1990 (2/3)/ 59, JP 63-021666 A (Ricoh Co. Ltd.)
4. Rene Ponut, Diccionario de la Edicion y de las Artes Graficas, 1990, Ediciones Piramide, Madrid, pp. 376, 603-605
5. Patent Abstract of Japan, CD-ROM PAJ MIJP 9408 PAJ 1994[06-209601/06-241600]/ 107/ JP 06-227176 A (Toppan Printing Co.)
6. China Abstract - CN 1074176 7/14/93

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